

9R340C-VB TO247 Datasheet Super Junction Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	900			
R _{DS(on)} typ. (Ω) at 25 °C	V _{GS} = 10 V	0.27		
Q _g max. (nC)	122			
Q _{gs} (nC)	14			
Q _{gd} (nC)	23			
Configuration	Single			

FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Qg)
- Avalanche energy rated (UIS)



APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
- Fluorescent ballast lighting
- Industrial
 - Welding
- Induction heating
- Motor drives
- Battery chargers
- Renewable energy
- Solar (PV inverters)

TO-247AC	ŏ
S	G S
	N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	900	V	
Gate-source voltage			V_{GS}	± 30	V	
Continuous drain current (T _J = 150 °C)	\/ at 10 \/	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		20		
	V _{GS} at 10 V	T _C = 100 °C	I _D	10	Α	
Pulsed drain current ^a			I _{DM}	60		
Linear derating factor				1.7	W/°C	
Single pulse avalanche energy b			E _{AS}	383	mJ	
Maximum power dissipation			P_{D}	218	W	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Drain-source voltage slope	T _J = 125 °C		dV/dt	70	V/ns	
Reverse diode dV/dt ^d			αν/αι	5.1	V/IIS	
Soldering recommendations (peak temperature) c	For	10 s		300	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. V_{DD} = 140 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 5.0 A
- c. 1.6 mm from case
- d. $I_{SD} \le I_D$, $dI/dt = 100 \text{ A/}\mu\text{s}$, starting $T_J = 25 \,^{\circ}\text{C}$



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	=	62	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	0.6		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		-					
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		900	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	1.08	-	V/°C
Gate-source threshold Voltage (N)	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0	-	4.0	V
Oata assura laskana		$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-source leakage	I _{GSS}	V _{GS} = ± 30 V		-	-	± 1	μΑ
		V _{DS} =	V _{DS} = 800 V, V _{GS} = 0 V		-	1	^
Zero gate voltage drain current	I _{DSS}	V _{DS} = 640 \	V _{DS} = 640 V, V _{GS} = 0 V, T _J = 125 °C		-	10	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 8.5 A	-	0.27	-	Ω
Forward transconductance	9 _{fs}	V _{DS} = 30 V, I _D = 8.5 A		-	8.7	-	S
Dynamic		•				•	
Input capacitance	C _{iss}	V _{GS} = 0 V,		-	2408	-	pF
Output capacitance	C _{oss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$		81	-	
Reverse transfer capacitance	C _{rss}	f = 1 MHz		-	9	-	
Effective output capacitance, energy related ^a	$C_{o(er)}$	V _{DS} = 0 V to 480 V, V _{GS} = 0 V		-	58	-	
Effective output capacitance, time related ^b	C _{o(tr)}			-	296	-	
Total gate charge	Qg			-	61	122	nC
Gate-source charge	Q_{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 8.5 \text{ A}, V_{DS} = 480 \text{ V}$	-	14	-	
Gate-drain charge	Q _{gd}	7		-	23	-	
Turn-on delay time	t _{d(on)}			-	22	44	- ns
Rise time	t _r	V _{DD} -	$V_{DD} = 480 \text{ V}, I_D = 8.5 \text{ A},$		24	48	
Turn-off delay time	t _{d(off)}	$V_{\rm DD} = 400 \text{ V}, \ R_{\rm g} = 9.1 \ \Omega$		-	71	142	
Fall time	t _f			-	26	52	
Gate input resistance	R_g	f = 1 MHz, open drain		0.3	0.7	1.4	Ω
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	15	
Pulsed diode forward current	I _{SM}			-	-	45	- A
Diode forward voltage	V _{SD}	T _J = 25 °C, I _S = 8.5 A, V _{GS} = 0 V		-	-	1.2	V
Reverse recovery time	t _{rr}	T _J = 25 °C, I _F = I _S = 8.5 A, dl/dt = 100 A/ μ s, V _R = 25 V		-	416	832	ns
Reverse recovery charge	Q _{rr}			_	6.4	12.8	μC
Reverse recovery current	I _{RRM}			_	27	_	A

Notes

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- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

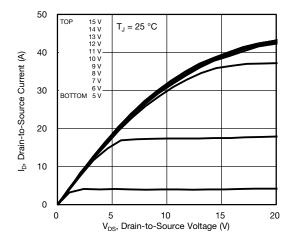


Fig. 1 - Typical Output Characteristics

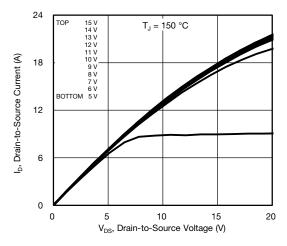


Fig. 2 - Typical Output Characteristics

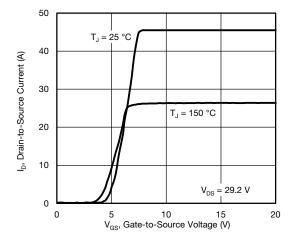


Fig. 3 - Typical Transfer Characteristics

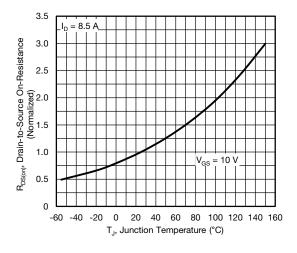


Fig. 4 - Normalized On-Resistance vs. Temperature

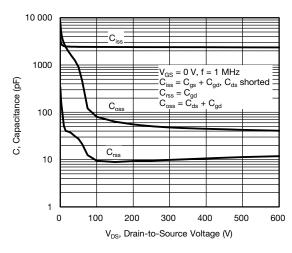


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

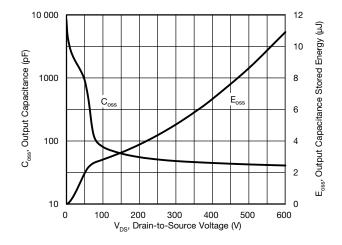


Fig. 6 - Coss and Eoss vs. VDS



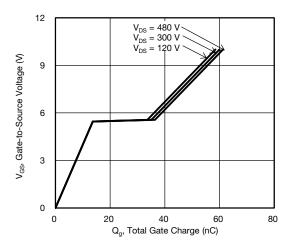


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

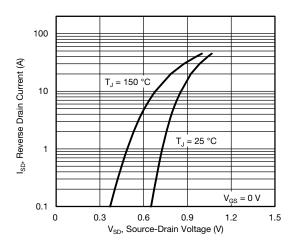


Fig. 8 - Typical Source-Drain Diode Forward Voltage

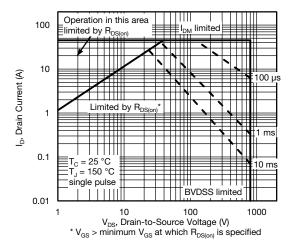


Fig. 9 - Maximum Safe Operating Area

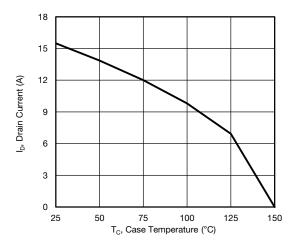


Fig. 10 - Maximum Drain Current vs. Case Temperature

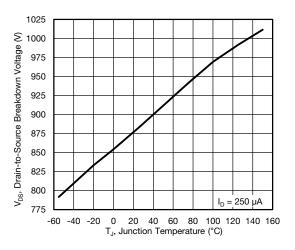


Fig. 11 - Temperature vs. Drain-to-Source Voltage

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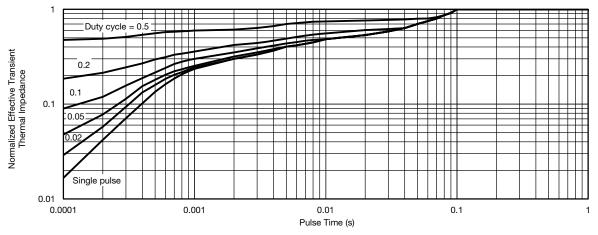


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

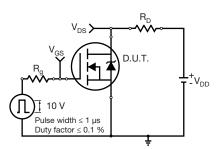


Fig. 13 - Switching Time Test Circuit

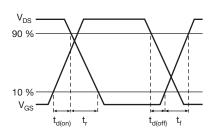


Fig. 14 - Switching Time Waveforms

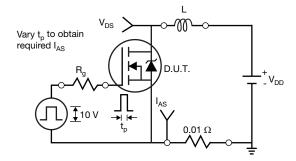


Fig. 15 - Unclamped Inductive Test Circuit

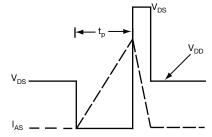


Fig. 16 - Unclamped Inductive Waveforms

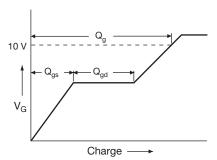


Fig. 17 - Basic Gate Charge Waveform

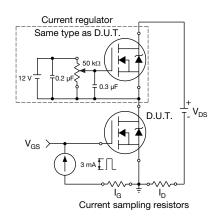
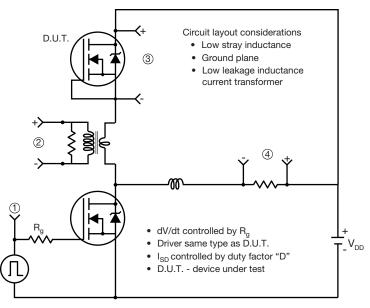


Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



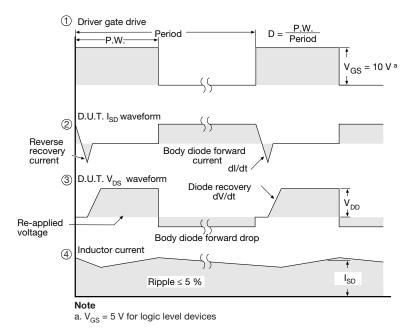


Fig. 19 - For N-Channel

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